

N-Channel Enhancement Mode Power MOSFET With ESD Protected



● Features

$V_{DS} = 20V$,

$I_D = 100A$

$R_{DS(ON)} @ V_{GS} = 4.5V$, typ=0.8m Ω

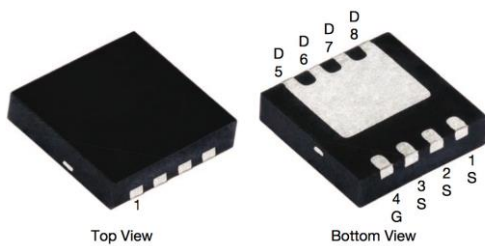
$R_{DS(ON)} @ V_{GS} = 2.5V$, typ=1.0m Ω

ESD Protected

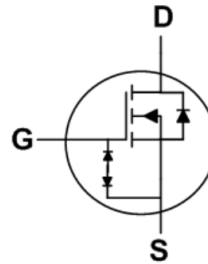
● General Description

- DC/DC power supplies
- High current power rails in computing
- Telecom POL and bricks
- Battery protection

● Pin Configurations



TDFN3.3*3.3-8L



● Absolute Maximum Ratings @ $T_A=25^\circ C$ unless otherwise noted

Parameter		Symbol	Ratings	Unit
Drain-Source Voltage		V_{DSS}	20	V
Gate-Source Voltage		V_{GSS}	± 12	V
Drain Current (Continuous) *C	$T_C=25^\circ C$	I_D	100	A
	$T_C=100^\circ C$		65	
Drain Current (Pulse) *B		I_{DM}	300	A
Power Dissipation	$T_C=25^\circ C$	P_D	75	W
Operating Temperature/ Storage Temperature		T_J/T_{STG}	-55~150	$^\circ C$

● Thermal Resistance Ratings

Parameter		Symbol	Maximum	Unit
Thermal Resistance Junction-ambient *A	$t \leq 10$ s	$R_{\theta JA}$	38	$^\circ C/W$
Thermal Resistance Junction-case *A	Steady state	$R_{\theta JC}$	2.9	

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● **Electrical Characteristics** @ $T_A=25^{\circ}\text{C}$ unless otherwise noted

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Static* D						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	20	--	--	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 16V, V_{GS} = 0V$	--	--	1	μA
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_{DS} = 250\mu A$	0.4	--	1.0	V
Gate Leakage Current	I_{GSS}	$V_{GS} = \pm 10V, V_{DS} = 0V$	--	--	± 10	μA
Drain-Source On-state Resistance	$R_{DS(on)}$	$V_{GS} = 10V, I_D = 20A$	--	0.8	1.0	m Ω
	$R_{DS(on)}$	$V_{GS} = 4.5V, I_D = 20A$	--	1.0	1.2	m Ω
	$R_{DS(on)}$	$V_{GS} = 2.5V, I_D = 20A$	--	1.2	1.8	m Ω
Diode Forward Voltage	V_{SD}	$I_{SD} = 1A, V_{GS} = 0V$	--	0.7	1.2	V
Diode Forward Current *C	I_S	$T_C = 25^{\circ}\text{C}$	--	--	100	A
Switching						
Total Gate Charge	Q_g	$V_{DS} = 10V, I_D = 20A,$ $V_{GS} = 10V$	--	85	--	nC
Gate-Source Charge	Q_{GS}		--	9.5	--	nC
Gate-Drain Charge	Q_{GD}		--	13	--	nC
Turn-on Delay Time	$t_{d(on)}$	$V_{DD} = 10V, R_L = 1\Omega,$ $V_{GEN} = 10V, I_D = 10A,$ $R_g = 1\Omega$	--	11	--	ns
Turn-on Rise Time	t_r		--	16	--	ns
Turn-off Delay Time	$t_{d(off)}$		--	54	--	ns
Turn-Off Fall Time	t_f		--	17	--	ns
Dynamic						
Input Capacitance	C_{iss}	$V_{DS} = 10V, V_{GS} = 0V, f = 1.0\text{MHz}$	--	5238	--	pF
Output Capacitance	C_{oss}		--	490	--	pF
Reverse Transfer Capacitance	C_{rss}		--	296	--	pF

A: The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^{\circ}\text{C}$. The value in any given application depends on the user's specific board design.

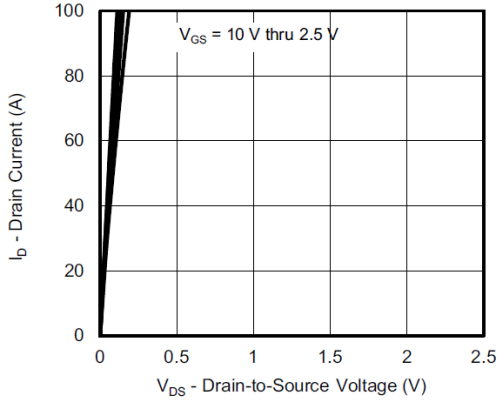
B: Repetitive rating, pulse width limited by junction temperature.

C: The current rating is based on the $\leq 10s$ junction to ambient thermal resistance rating, Package Limited 100A.

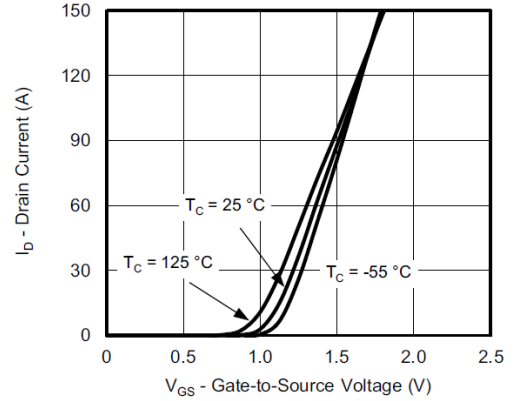
D: Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycles $\leq 2\%$.

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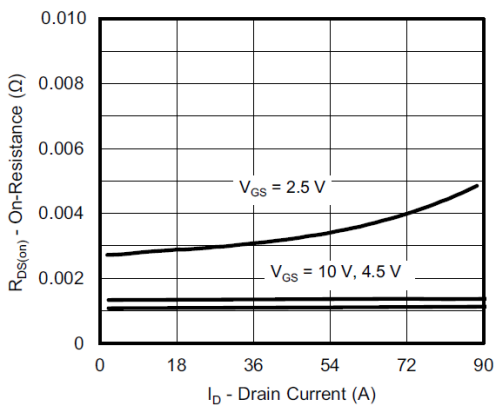
Typical Performance Characteristics ((T_J = 25 °C, unless otherwise noted))



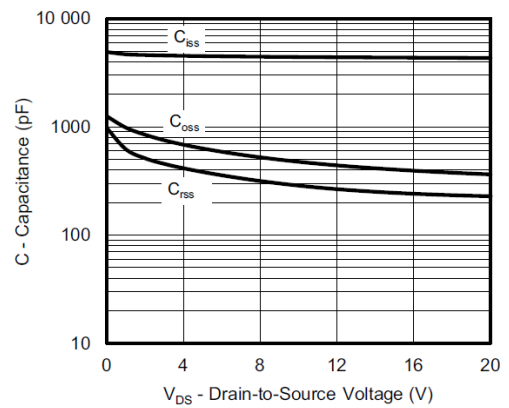
Output Characteristics



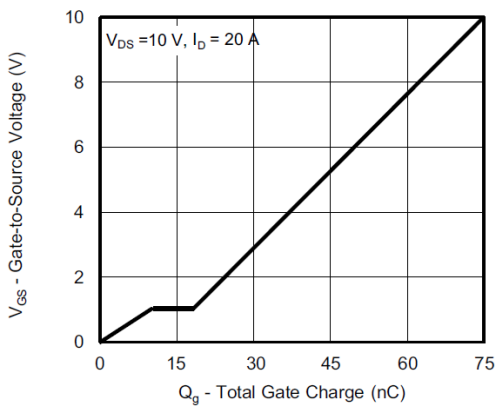
Transfer Characteristics



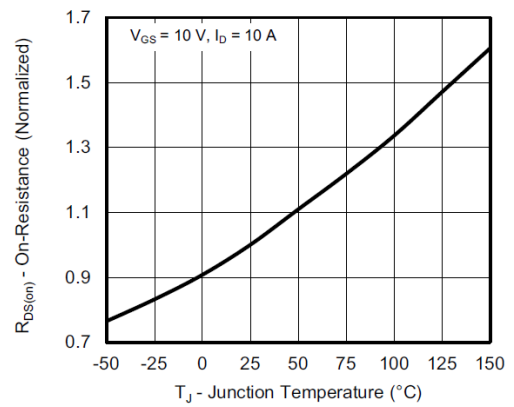
On-Resistance vs. Drain Current and Gate Voltage



Capacitance

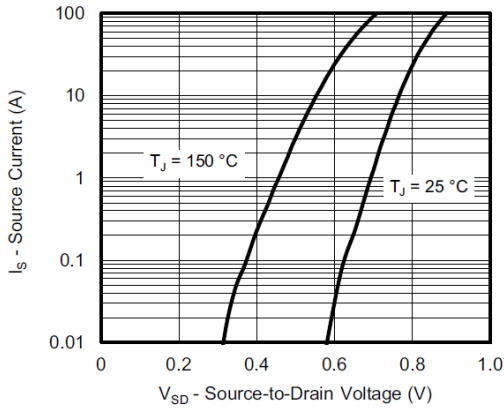


Gate Charge

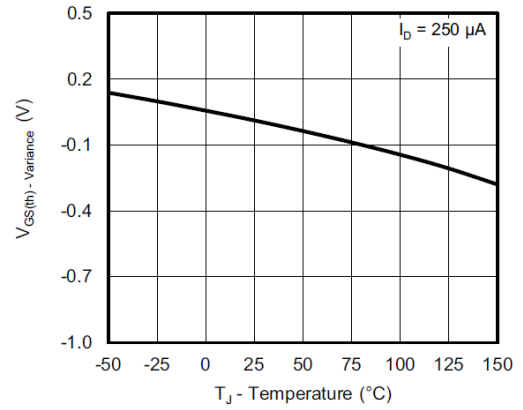


On-Resistance vs. Junction Temperature

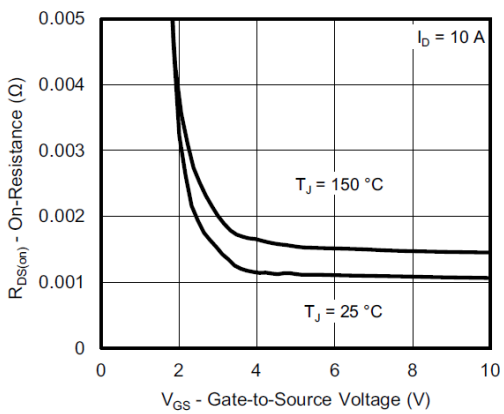
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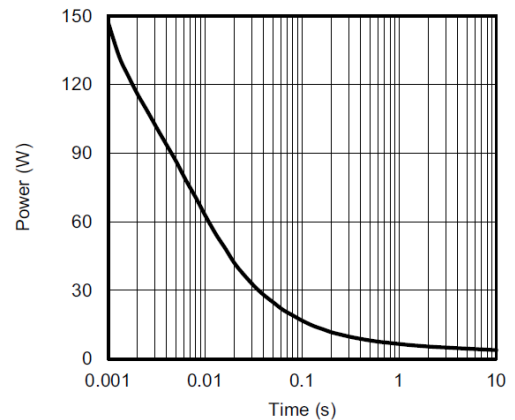
Source-Drain Diode Forward Voltage



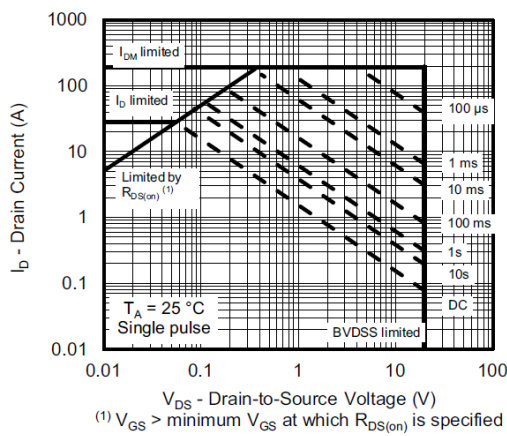
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage



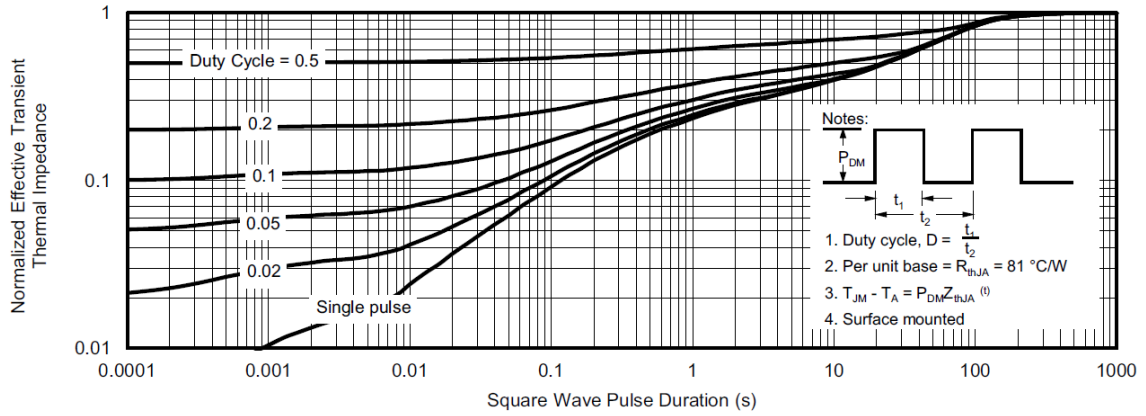
Single Pulse Power, Junction-to-Ambient



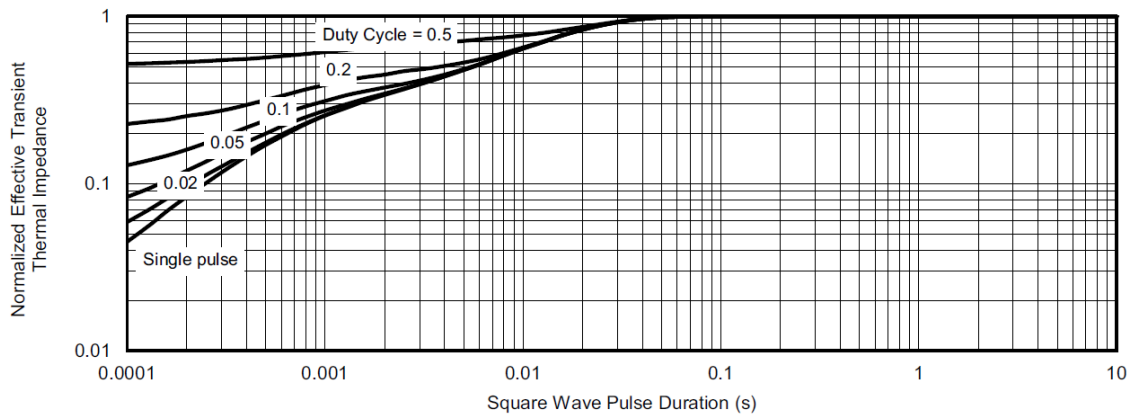
(1) $V_{GS} >$ minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient

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Normalized Thermal Transient Impedance, Junction-to-Ambient

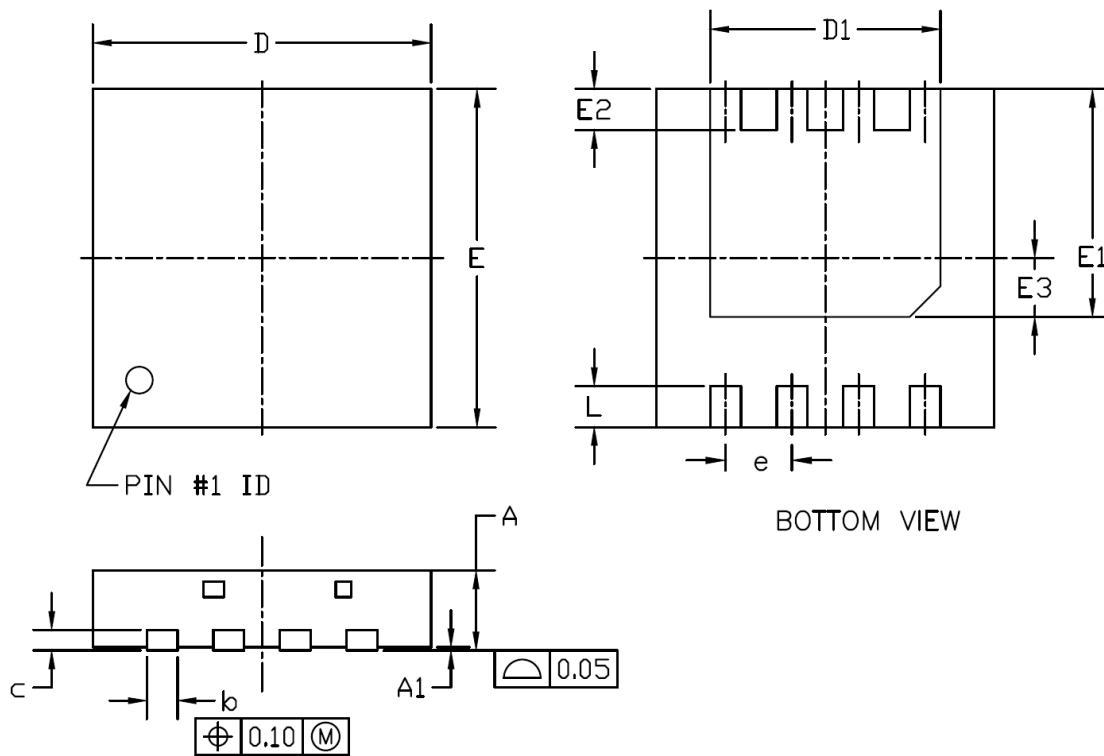


Normalized Thermal Transient Impedance, Junction-to-Case

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- Package Information

TDFN3.3*3.3-8L



SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES		
	MIN	NOM	MAX	MIN	NOM	MAX
A	0.70	0.75	0.80	0.028	0.030	0.031
A1	--	--	0.05	--	--	0.002
b	0.24	0.30	0.35	0.009	0.012	0.014
c	0.10	0.15	0.25	0.004	0.006	0.010
D	3.20	3.30	3.40	0.126	0.130	0.134
D1	2.15	2.25	2.35	0.085	0.089	0.093
E	3.20	3.30	3.40	0.126	0.130	0.134
E1	2.13	2.23	2.33	0.084	0.088	0.092
E2	0.30	0.40	0.50	0.012	0.016	0.020
E3	0.48	0.58	0.68	0.019	0.023	0.027
e	0.65 BSC			0.026 BSC		
L	0.30	0.40	0.50	0.012	0.016	0.020

NOTE

1. CONTROLLING DIMENSION IS MILLIMETER.
CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.